

# **TL494 Pulse-Width-Modulation Control Circuits**

### **FEATURES**

- Complete PWM Power-Control Circuitry
- Uncommitted Outputs for 200-mA Sink or Source Current
- Output Control Selects Single-Ended or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply With 5% Tolerance
- Circuit Architecture Allows Easy Synchronization

### DESCRIPTION

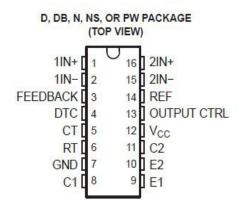
The TL494 device incorporates all the functions required in the construction of a pulse-width-modulation (PWM) control circuit on a single chip. Designed primarily for power-supply control, this device offers the flexibility to tailor the power-supply control circuitry to a specific application.

The TL494 device contains two error amplifiers, an on-chip adjustable oscillator, a dead-time control (DTC) comparator, a pulse-steering control flip-flop, a 5-V, 5%-precision regulator, and output-control circuits.

The error amplifiers exhibit a common-mode voltage range from  $-0.3 \ V$  to  $V_{CC} - 2 \ V$ . The dead-time control comparator has a fixed offset that provides approximately 5% dead time. The on-chip oscillator can be bypassed by terminating RT to the reference output and providing a sawtooth input to CT, or it can drive the common circuits in synchronous multiple-rail power supplies.

The uncommitted output transistors provide either common-emitter or emitter-follower output capability. The TL494 device provides for push-pull or single-ended output operation, which can be selected through the output-control function. The architecture of this device prohibits the possibility of either output being pulsed twice during push-pull operation.

The TL494C device is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C. The TL494I device is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.





# **Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
Vcc	Supply voltage <sup>(2)</sup>			41	٧
VI	Amplifier input voltage		V	cc + 0.3	٧
Vo	Collector output voltage			41	٧
lo	Collector output current			250	mA
	•	D package		73	
		DB package		82	
$\theta_{JA}$	Package thermal impedance (3)(4)	N package		67	°C/W
		NS package		64	
		PW package		108	
	Lead temperature 1,6 mm (1/16 inch) from case for	10 seconds		260	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# **Recommended Operating Conditions**

			MIN	MAX	UNIT
V <sub>cc</sub>	Supply voltage		7	40	٧
VI	Amplifier input voltage		-0.3	V <sub>CC</sub> -2	٧
Vo	Collector output voltage			40	٧
	Collector output current (each transistor)		8	200	mA
	Current into feedback terminal		8	0.3	mA
fosc	Oscillator frequency		1	300	kHz
C <sub>T</sub>	Timing capacitor		0.47	10000	nF
R <sub>T</sub>	Timing resistor		1.8	500	kΩ
_	0	TL494C	0	70	00
TA	Operating free-air temperature	TL494I	-40	85	°C

 <sup>(2)</sup> All voltages are with respect to the network ground terminal.
 (3) Maximum power dissipation is a function of T<sub>J</sub>(max), θ<sub>JA</sub>, and T<sub>A</sub>. The maximum allowable power dissipation at any allowable ambient temperature is P<sub>D</sub> = (T<sub>J</sub>(max) – T<sub>A</sub>)/θ<sub>JA</sub>. Operating at the absolute maximum T<sub>J</sub> of 150°C can affect reliability.
 (4) The package thermal impedance is calculated in accordance with JESD 51-7.



#### **Electrical Characteristics**

over recommended operating free-air temperature range, V<sub>CC</sub> = 15 V, f = 10 kHz (unless otherwise noted)

# Reference Section

PARAMETER	TEST CONDITIONS <sup>(1)</sup>	TL494C, TL494I			
PARAMETER		MIN	TYP(2)	MAX	UNIT
Output voltage (REF)	I <sub>O</sub> = 1 mA	4.75	5	5.25	٧
Input regulation	V <sub>CC</sub> = 7 V to 40 V		2	25	mV
Output regulation	I <sub>O</sub> = 1 mA to 10 mA		1	15	mV
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$		2	10	mV/V
Short-circuit output current <sup>(3)</sup>	REF = 0 V		25		mA

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
- (2) All typical values, except for parameter changes with temperature, are at T<sub>A</sub> = 25°C.
   (3) Duration of short circuit should not exceed one second.

### **Oscillator Section**

 $C_T = 0.01 \,\mu\text{F}, \, R_T = 12 \,\text{k}\Omega \,(\text{see Figure 1})$ 

PARAMETER	TEST COMPITIONS(1)	TL494C, TL494I	UNIT	
PARAMETER	TEST CONDITIONS <sup>(1)</sup>	MIN TYP(2) MAX		
Frequency		10	kHz	
Standard deviation of frequency <sup>(3)</sup>	All values of V <sub>CC</sub> , C <sub>T</sub> , R <sub>T</sub> , and T <sub>A</sub> constant	100	Hz/kHz	
Frequency change with voltage	V <sub>CC</sub> = 7 V to 40 V, T <sub>A</sub> = 25°C	1	Hz/kHz	
Frequency change with temperature (4)	$\Delta T_A = MIN \text{ to MAX}$	10	Hz/kHz	

- (1) For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
- All typical values, except for parameter changes with temperature, are at T<sub>A</sub> = 25°C.

  Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

(4) Temperature coefficient of timing capacitor and timing resistor are not taken into account.

# **Error-Amplifier Section**

See Figure 2

DADAMETED	TEST COMPLETIONS	TL494C, TL494I			
PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
Input offset voltage	V <sub>O</sub> (FEEDBACK) = 2.5 V		2	10	mV
Input offset current	V <sub>O</sub> (FEEDBACK) = 2.5 V		25	250	nA
Input bias current	V <sub>O</sub> (FEEDBACK) = 2.5 V		0.2	1	μA
Common-mode input voltage range	V <sub>CC</sub> = 7 V to 40 V	-0.3 to V <sub>CC</sub> - 2			٧
Open-loop voltage amplification	$\Delta V_0 = 3 \text{ V}, V_0 = 0.5 \text{ V to } 3.5 \text{ V}, R_L = 2 \text{ k}\Omega$	70	95		dB
Unity-gain bandwidth	$V_0 = 0.5 \text{ V to } 3.5 \text{ V}, R_L = 2 \text{ k}\Omega$		800		kHz
Common-mode rejection ratio	ΔV <sub>O</sub> = 40 V, T <sub>A</sub> = 25°C	65	80	63	dB
Output sink current (FEEDBACK)	$V_{ID}$ = -15 mV to -5 V, V (FEEDBACK) = 0.7 V	0.3	0.7		mA
Output source current (FEEDBACK)	V <sub>ID</sub> = 15 mV to 5 V, V (FEEDBACK) = 3.5 V	-2			mA

(1) All typical values, except for parameter changes with temperature, are at T<sub>A</sub> = 25°C.



### **Electrical Characteristics**

over recommended operating free-air temperature range,  $V_{CC}$  = 15 V, f = 10 kHz (unless otherwise noted)

### **Output Section**

PARAMETER  Collector off-state current		TEST CONDITIONS	MIN	TYP(1)	MAX	UNIT
		V <sub>CE</sub> = 40 V, V <sub>CC</sub> = 40 V	910	2	100	μA
Emitter off-state current		V <sub>CC</sub> = V <sub>C</sub> = 40 V, V <sub>E</sub> = 0			-100	μA
	Common emitter	V <sub>E</sub> = 0, I <sub>C</sub> = 200 mA		1.1	1.3	
Collector-emitter saturation voltage Emitter follower		V <sub>O(C1 or C2)</sub> = 15 V, I <sub>E</sub> = -200 mA		1.5	2.5	V
Output control input current		V <sub>I</sub> = V <sub>ref</sub>			3.5	mA

<sup>(1)</sup> All typical values, except for temperature coefficient, are at T<sub>A</sub> = 25°C.

# **Dead-Time Control Section**

See Figure 1

PARAMETER	TEST CONDITIONS	MIN TYP(1)	MAX	UNIT
Input bias current (DEAD-TIME CTRL)	V <sub>I</sub> = 0 to 5.25 V	-2	-10	μΑ
Maximum duty cycle, each output	$V_I$ (DEAD-TIME CTRL) = 0, $C_T$ = 0.01 $\mu$ F, $R_T$ = 12 $k\Omega$	45		%
Input threehold veltage (DEAD TIME CTDL)	Zero duty cycle	3	3.3	V
Input threshold voltage (DEAD-TIME CTRL)	Maximum duty cycle	0		٧

<sup>(1)</sup> All typical values, except for temperature coefficient, are at T<sub>A</sub> = 25°C.

# **PWM Comparator Section**

See Figure 1

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
Input threshold voltage (FEEDBACK)	Zero duty cyle	93	4	4.5	V
Input sink current (FEEDBACK)	V (FEEDBACK) = 0.7 V	0.3	0.7		mA

<sup>(1)</sup> All typical values, except for temperature coefficient, are at T<sub>A</sub> = 25°C.

### **Total Device**

PARAMETER	TEST CONDIT	TIONS	MIN TYP <sup>(1)</sup>	MAX	UNIT
Ctan dhu annah annant	$R_T = V_{ref}$	V <sub>CC</sub> = 15 V	6	10	Л
Standby supply current	All other inputs and outputs open	V <sub>CC</sub> = 40 V	9	15	mA
Average supply current	V <sub>I</sub> (DEAD-TIME CTRL) = 2 V, See Fig	V <sub>I</sub> (DEAD-TIME CTRL) = 2 V, See Figure 1			mA

<sup>(1)</sup> All typical values, except for temperature coefficient, are at TA = 25°C.

# Switching Characteristics

 $T_A = 25^{\circ}C$ 

PARAMETER TEST CONDITIONS		MIN TYP(1)	MAX	UNIT
Rise time  Common-emitter configuration, See Figure 3		100	200	ns
Fall time	Common-emitter configuration, See Figure 3	25	100	ns
Rise time	Faither fellower conferentian Con Figure 4	100	200	ns
Fall time	Emitter-follower configuration, See Figure 4	40	100	ns

<sup>(1)</sup> All typical values, except for temperature coefficient, are at T<sub>A</sub> = 25°C.